

<b>Notice of References Cited</b>	Application/Control No. 10/816,168		Applicant(s)/Patent Under Reexamination NAKADA ET AL.	
	Examiner EDNA WONG		Art Unit 1795	Page 1 of 1

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*	B	US-6,989,084	01-2006	Tench et al.	204/275.1
*	C	US-6,113,771	09-2000	Landau et al.	205/123
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	K	US-			
	L	US-			
	M	US-			

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**NON-PATENT DOCUMENTS**

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